



Test Report : SPAN02W8-03

2W SIP Package 8:1 Ultra-Wide Input DC-DC Regulated Converter

■ DESIGN VERIFY TEST

Output Function Test

Input Function Test

Protection Function Test

■ SAFETY TEST

Safety test

■ RELIABILITY TEST

Environment Test

DESIGN VERIFY TEST

OUTPUT FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	VOLTAGE ACCURACY	-1.5% ~ +1.5 % (Max)	I/P:48VDC O/P:FULL LOAD Ta:25°C	-0.33%	P
2	RIPPLE & NOISE	75 mVp-p (Max)	I/P:48VDC O/P:FULL LOAD Ta:25°C	6 mV	P
3	LINE REGULATION	-0.5% ~ +0.5 %	I/P:9VDC~75VDC O/P:FULL LOAD Ta:25°C	+0.00% ~ -0.11%	P
4	LOAD REGULATION	-0.5% ~ +0.5%	I/P:48VDC O/P:0% LOAD~FULL LOAD Ta:25°C	-0.20% ~ +0.22%	P

INPUT FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	EFFICIENCY	77%	I/P:48VDC O/P:FULL LOAD Ta:25°C	78.06%	P
2	DC CURRENT	45 mA / FULL LOAD 6 mA / NO LOAD	I/P:48VDC O/P:NO / FULL LOAD Ta:25°C	43.69 mA / FULL LOAD 1.4 mA / NO LOAD	P
3	UNDER VOLTAGE LOCKOUT	START-UP 8.8V SHUTDOWN VOLTAGE 8.0V	I/P:TESTING O/P:FULL LOAD Ta:25°C	8.12 VDC 7.53 VDC	P

PROTECTION FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	SHORT PROTECTION	CONTINUOUS	I/P:75VDC O/P:FULL LOAD Ta:25°C	CONTINUOUS, AUTOMATIC RECOVERY	P
2	OVER LOAD PROTECTION	110~230%	I/P:48VDC O/P:TESTING Ta:25°C	136.0% HICCUP MODE AUTO-RECOVER	P
3	CASE TEMPERATURE	+110°C max	I/P:48VDC O/P:TESTING Ta: TESTING	OK AUTOMATIC RECOVERY	P

CONTROL FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	REMOTE CONTROL	Power on : R.C <R.C.~-Vin<1.2Vdc or open Power off : R.C. ~-Vin >5.5 ~ 15Vdc	I/P:48VDC O/P:100% LOAD Ta:25°C	Power on : R.C<2.52Vdc or Open Power off : R.C ◦ >2.53Vdc or Short	P

SAFETY TEST

SAFETY TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	WITHSTAND VOLTAGE	I/P-O/P:3000 VDC/min	I/P-O/P:3000 VDC/min Ta:25°C	I/P-O/P: 0.002mA NO DAMAGE	P
2	ISOLATION RESISTANCE	I/P-O/P:500VDC>1000MΩ	I/P-O/P:500 VDC Ta:25°C	I/P-O/P>1000MΩ NO DAMAGE	P

RELIABILITY TEST

ENVIRONMENT TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT										
1	TEMPERATURE RISE TEST	1. ROOM AMBIENT BURN-IN : 4HRS I/P:48VDC O/P:FULL LOAD Ta=25°C 2. HIGH AMBIENT BURN-IN : 4HRS I/P:48VDC O/P:FULL LOAD Ta=85°C 3. HIGH AMBIENT BURN-IN : 4HRS I/P:48VDC O/P:60% LOAD Ta=95°C	<table border="1"> <thead> <tr> <th>NO</th><th>Position</th><th>1</th><th>2</th><th>3</th></tr> </thead> <tbody> <tr> <td>1</td><td>CASE</td><td>50.9°C</td><td>103.4°C</td><td>110.9°C</td></tr> </tbody> </table>	NO	Position	1	2	3	1	CASE	50.9°C	103.4°C	110.9°C	
NO	Position	1	2	3										
1	CASE	50.9°C	103.4°C	110.9°C										
2	LOW TEMPERATURE TURN ON TEST	TURN ON AFTER 4 HOURS	I/P:48VDC O/P: FULL LOAD Ta= -40°C	TEST : OK										

OTHER

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT
1	MTBF	MIL-HDBK-217F,GB,25°C TOTAL FAILURE RATE : 0.54054 M.T.B.F : 1,850KHRS		

TEST RESULT	TESTER	APPROVAL
PASS	ARCHEN HSIAO	PETER CHENG